



超高绝缘
Ultra-high insulation

最大检测点数512Pins
Maximum inspection points
512 pins

高速度、高精度
High speed / high accuracy

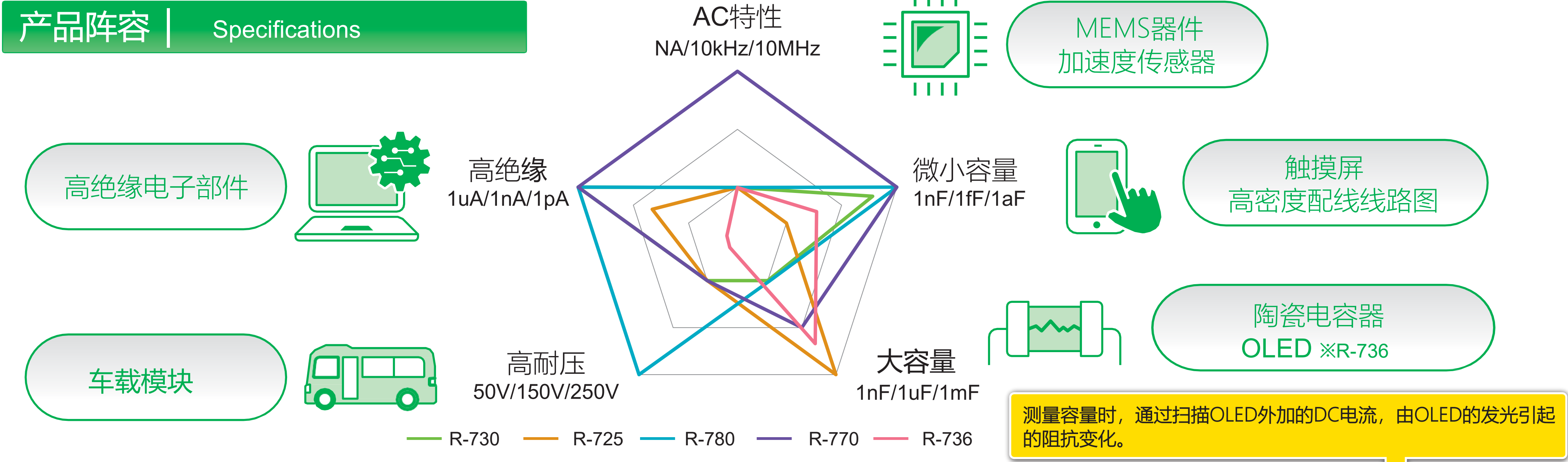
微小容量检测、高分辨率
Micro-Capacity Inspection
High resolution

紧凑型设计
Compact Designs

4W低电阻测定0.1mΩ ~
4W low resistance
measurement 0.1mΩ ~

可对应薄膜射频滤波器 / 车载DC模块 / 加速度传感器 / MEMS器件等产品的检测
Thin-film RF filters/Vehicle DC modules/Accelerometers/MEMS devices, Any products can be inspected!

产品阵容 | Specifications



Item		R-730 Standard	R-725 Low Impedance	R-780 High Insulation	R-770 AC Dynamic	R-736 Sweep Test
Resistance		20V/0.2mA ~ 20mA 1mΩ ~ 10MΩ	24V/0.2mA ~ 40mA 0.1mΩ ~ 10MΩ	24V/0.2mA ~ 40mA 0.1mΩ ~ 10MΩ	24V/0.2mA ~ 40mA 0.1mΩ ~ 10MΩ	±10V/±40mA (OP)
Leakage		10V ~ 50V/1mA ~ 20mA 1MΩ ~ 1GΩ	10V ~ 50V/1mA ~ 20mA 1MΩ ~ 1GΩ	0.1V ~ 250V/1mA ~ 20mA 1MΩ ~ 10TΩ	0.1V ~ 50V/1mA ~ 20mA 1MΩ ~ 10TΩ	±10V/±40mA (OP)
Capacitance	Voltage	2V ~ 15Vrms	5mV ~ 15Vrms	5mV ~ 15Vrms	5mV ~ 15Vrms	100mV ~ 5Vrms
	Frequency	10kHz ~ 1MHz	100Hz ~ 1MHz	1kHz ~ 1MHz	1kHz ~ 1MHz	1kHz
	Range	0.01pF ~ 2000pF	1nF ~ 10mF	0.01pF ~ 2000pF	0.01pF ~ 2000pF	10nF ~ 10uF
	Min. Resolution	0.01fF	0.1pF	0.001fF	0.001fF	1pF
	Sweep Mode	NA	NA	NA	NA	AC_current, DC_current
AWG	Bandwidth	NA	NA	NA	DC ~ 20MHz	NA
	Max.UpdateRate				50MS/s	
	Resolution				16bit	
Digitizer	Max.SampleRate	NA	NA	NA	15MS/s	NA
	Resolution				18bit	

外观及规格如有变更，恕不另行通知。